

**Search Notes**

Application/Control No.

10/537,290

Examiner

Sin J. Lee

Applicant(s)/Patent under  
Reexamination

HIRAYAMA ET AL.

Art Unit

1795

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east text search	5/12/2008	SJL